


<b>Search Notes</b>  	<b>Application/Control No.</b>  10596312	<b>Applicant(s)/Patent Under Reexamination</b>  TSUKIZAWA ET AL.
	<b>Examiner</b>  THIEM PHAN	<b>Art Unit</b>  3729

SEARCHED			
Class	Subclass	Date	Examiner
29	851, 830, 832, 834, 837, 846, 854	5/07/09	TP
174	255, 260, 261	"	"
257	E21.705, E23.009, E23.173	"	"

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search Attached	5/07/09	TP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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